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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> <i>(use as many sheets as necessary)</i>				Application Number	10/628,239
				Filing Date	July 29, 2003
				First Named Inventor	Koji MORIYA et al.
				Art Unit	2818
				Examiner Name	Dung Anh Le
Sheet	1	of	1	Attorney Docket Number	740756-2638

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>5</sup>
De		R. MARTEL et al.; "Single and Multi-Well Carbon Nanotube Field-Effect Transistors"; Appl. Phys. Lett., 10/26/1998, Vol. 73, No. 17; pp. 2447-2449.	
		K. LIU et al.; "Conductance Spikes in Single-Walled Carbon Nanotube Field-Effect"; Appl. Phys. Lett., 10/18/1999; Vol. 75, No. 16; pp. 2494-2496.	
		T. YAMADA; "Analysis of Submicron Carbon Nanotube Field-Effect Transistors"; Appl. Phys. Lett., 01/31/2000; Vol. 76, No. 5; pp. 628-630.	
		A. BACHTOLD et al.; "Contacting Carbon Nanotubes Selectively with Low-Ohmic Contacts for Four-Probe Electric Measurements"; Appl. Phys. Lett., 07/13/1998; Vol. 73, No. 2, pp. 274-276.	
		S. FRANK et al.; "Carbon Nanotube Quantum Resistors"; Science, 06/12/1998; Vol. 280, pp. 1744-1746.	
		M. BOCKRATH et al.; "Single-Electron Transport in Ropes of Carbon Nanotubes"; Science, 03/28/1997, Vol. 275, pp. 1922-1925.	
De		"Carbon Nanotube - Progressing Material Development Technique and Development of Application - (with a partial translation)"; 04/26/2002; pp. 157-158.	
Examiner Signature	De		Date Considered Jan-2006

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